

# FQU6N25-VB Datasheet

## **Power MOSFET**

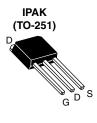
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	250				
R <sub>DS(on)</sub> (Ω)	$V_{GS} = 10 V$	1.1			
Q <sub>g</sub> (Max.) (nC)	14				
Q <sub>gs</sub> (nC)	2.7				
Q <sub>gd</sub> (nC)	7.8				
Configuration	Single				

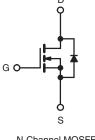
## **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Available in Tape and Reel
- · Fast Switching
- · Ease of Paralleling



COMPLIANT HALOGEN FREE Available





N-Channel MOSFET

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	250	v	
Gate-Source Voltage			V <sub>GS</sub>	± 20	v	
Continuous Drain Current	$V_{GS} \text{ at 10 V} \qquad \frac{T_C = 25 \text{ °C}}{T_C = 100 \text{ °C}}$	T <sub>C</sub> = 25 °C		3.8		
		I <sub>D</sub>	2.4	А		
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	15		
Linear Derating Factor				0.33	W/00	
Linear Derating Factor (PCB Mount) <sup>e</sup>				0.020	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	130	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	3.8	Α	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	4.2	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		D	42	w	
Maximum Power Dissipation (PCB Mount) <sup>e</sup>	T <sub>A</sub> = 25 °C		P <sub>D</sub> 2.5		~ ~ ~	
Peak Diode Recovery dV/dtc			dV/dt	4.8	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) <sup>d</sup>	for 10 s			260		

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b.  $V_{DD} = 50 \text{ V}$ ; starting  $T_J = 25 \text{ °C}$ , L = 14 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 3.8 \text{ A}$  (see fig. 12). c.  $I_{SD} \le 3.8 \text{ A}$ , dl/dt  $\le 90 \text{ A/}\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150 \text{ °C}$ .

d. 1.6 mm from case.

e. When mounted on 1" square PCB (FR-4 or G-10 material) .



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	R <sub>thJA</sub>	-	50			
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	110	°C/W		
Maximum Junction-to-Case	R <sub>thJC</sub>	-	3.0			

#### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static				1	1	1	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$		250	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	Reference to 25 °C, I <sub>D</sub> = 1 mA		0.36	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$		-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		$V_{GS} = \pm 20 \text{ V}$		-	± 100	nA
		V <sub>DS</sub> = 250 V, V <sub>GS</sub> = 0 V		-	-	25	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 200 \	∕, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 V$	I <sub>D</sub> = 2.3 A <sup>b</sup>	-	1.1	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	= 50 V, I <sub>D</sub> = 2.3 A <sup>b</sup>	1.5	-	-	S
Dynamic					•	•	
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V,		260	-	
Output Capacitance	Coss	1	$V_{DS} = 25 V,$	-	77	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 MHz, see fig. 5 <sup>c</sup>		-	15	-	1
Total Gate Charge	Qg			-	-	14	
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 V$	$V_{GS} = 10 \text{ V} \qquad \begin{array}{c} I_D = 4.4 \text{ A}, V_{DS} = 200 \text{ V}, \\ \text{see fig. 6 and } 13^{\text{b, c}} \end{array}$		-	2.7	nC
Gate-Drain Charge	Q <sub>gd</sub>				-	7.8	
Turn-On Delay Time	t <sub>d(on)</sub>		V <sub>DD</sub> = 125 V, I <sub>D</sub> = 4.4 A,		7.0	-	- ns
Rise Time	t <sub>r</sub>	V <sub>DD</sub> =			13	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	$\label{eq:RG} \begin{split} R_{G} &= 18\ \Omega,\ R_{D} = 28\ \Omega,\\ & see\ fig.\ 10^{b,\ c} \end{split}$		-	20	-	
Fall Time	t <sub>f</sub>			-	12	-	
Internal Drain Inductance	L <sub>D</sub>		Between lead, 6 mm (0.25") from		4.5	-	
Internal Source Inductance	L <sub>S</sub>	die contact		-	7.5	-	nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	3.8	Α
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	15	
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C	$T_J = 25 \ ^{\circ}C, \ I_S = 3.8 \ A, \ V_{GS} = 0 \ V^b$		-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25 \text{ °C}, I_F = 4.4 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^{b}$		-	200	400	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.93	1.9	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	ırn-on time is negligible (turn	-on is dor	ninated b	y L <sub>S</sub> and	L <sub>D</sub> )

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

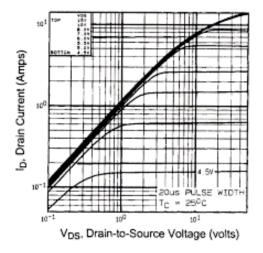


Fig. 1 - Typical Output Characteristics,  $T_C = 25 \ ^{\circ}C$ 

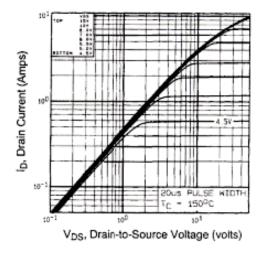


Fig. 2 - Typical Output Characteristics,  $T_C$  = 150  $^\circ C$ 

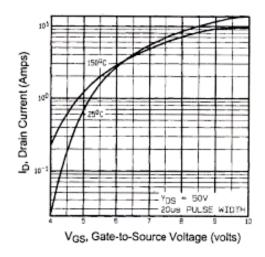


Fig. 3 - Typical Transfer Characteristics

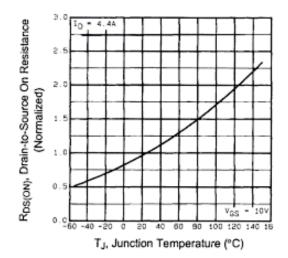
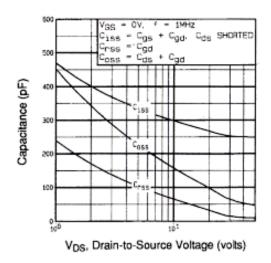
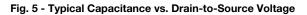
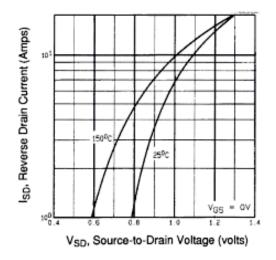


Fig. 4 - Normalized On-Resistance vs. Temperature











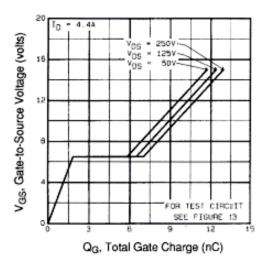


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

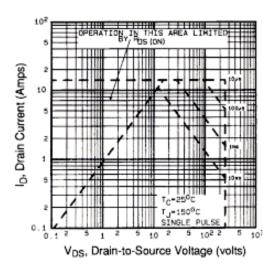


Fig. 8 - Maximum Safe Operating Area



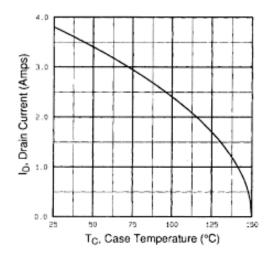


Fig. 9 - Maximum Drain Current vs. Case Temperature

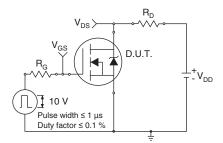


Fig. 10a - Switching Time Test Circuit

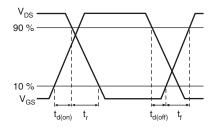


Fig. 10b - Switching Time Waveforms

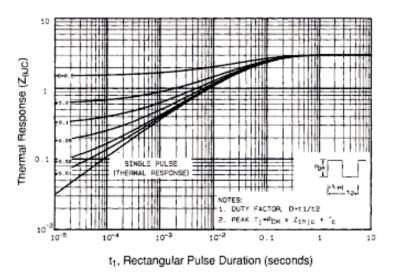


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



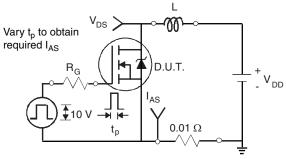


Fig. 12a - Unclamped Inductive Test Circuit

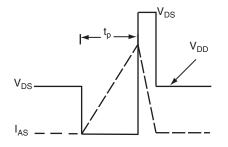


Fig. 12b - Unclamped Inductive Waveforms

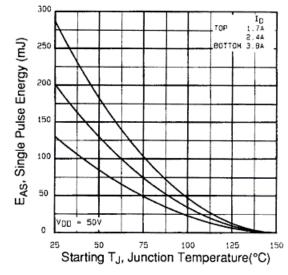


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

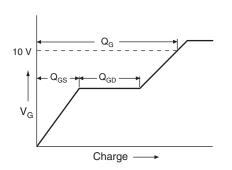


Fig. 13a - Basic Gate Charge Waveform

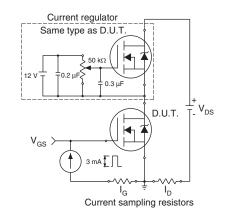


Fig. 13b - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit

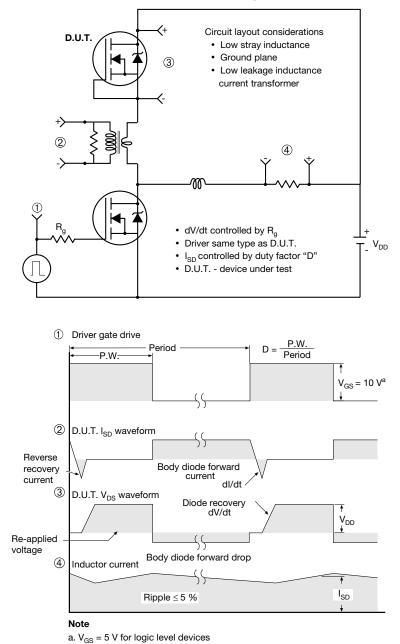
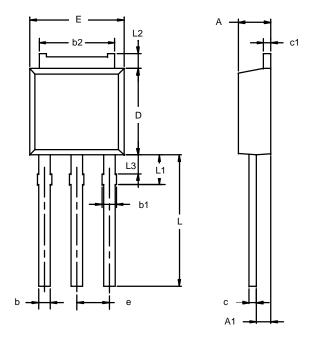


Fig. 14 - For N-Channel



## **TO-251AA**



	MILLIMETERS		INC	HES
Dim	Min	Max	Min	Max
Α	2.21	2.38	0.087	0.094
A1	0.89	1.14	0.035	0.045
b	0.71	0.89	0.028	0.035
b1	0.76	1.14	0.030	0.045
b2	5.23	5.43	0.206	0.214
С	0.46	0.58	0.018	0.023
c1	0.46	0.58	0.018	0.023
D	5.97	6.22	0.235	0.245
E	6.48	6.73	0.255	0.265
е	2.28	BSC	0.090	BSC
L	3.89	9.53	0.153	0.375
L1	1.91	2.28	0.075	0.090
L2	0.89	1.27	0.035	0.050
L3	1.15	1.52	0.045	0.060

Note: Dimension L3 is for reference only.



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